

Notice of References Cited	Application/Control No. 10/713,625		Applicant(s)/Patent Under Reexamination KARR ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,548,814 A	08-1996	Lorang et al.	370/310
*	B	US-5,442,646 A	08-1995	Chadwick et al.	714/795
*	C	US-5,732,333	03-1998	Cox et al.	455/126
*	D	US-4,856,003	08-1989	Weng, Lih-Jyh	714/784
*	E	US-5,487,089	01-1996	Misaizu et al.	375/296
*	F	US-6,567,397	05-2003	Campana et al.	370/349
*	G	US-2002/0194570 A1	12-2002	Birru et al.	714/792
*	H	US-2002/0090938 A1	07-2002	Dharia et al.	455/422
*	I	US-5,440,559	08-1995	Gaskill, Garold B.	370/314
*	J	US-5,168,271	12-1992	Hoff, Don G.	340/7.43
*	K	US-5,570,369	10-1996	Jokinen, Harri	370/311
*	L	US-6,192,253	02-2001	Charlier et al.	455/575.7
*	M	US-6,233,711	05-2001	Murayama et al.	714/786

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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